## BAS16VV; BAS16VY

# Triple high-speed switching diodes Rev. 03 — 20 April 2007

**Product data sheet** 

## **Product profile**

#### 1.1 General description

Triple high-speed switching diodes, encapsulated in very small Surface-Mounted Device (SMD) plastic packages.

Table 1. **Product overview** 

Type number	Package		Configuration
	NXP	JEITA	
BAS16VV	SOT666	-	triple isolated
BAS16VY	SOT363	SC-88	

#### 1.2 Features

- High switching speed:  $t_{rr} \le 4$  ns
- Low leakage current

- Reverse voltage: V<sub>R</sub> ≤ 100 V
- Very small SMD plastic packages

### 1.3 Applications

- High-speed switching
- General-purpose switching
- Voltage clamping
- Reverse polarity protection

#### 1.4 Quick reference data

Table 2. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode						
I <sub>F</sub>	forward current		-	-	200	mA
$V_R$	reverse voltage		-	-	100	V
t <sub>rr</sub>	reverse recovery time		<u>[1]</u> _	-	4	ns

[1] When switched from  $I_F$  = 10 mA to  $I_R$  = 10 mA;  $R_L$  = 100  $\Omega$ ; measured at  $I_R$  = 1 mA.



## 2. Pinning information

Table 3. Pinning

Pin	Description	Simplified outline	Symbol
1	anode (diode 1)		
2	anode (diode 2)	6   5   4	6 5 4
3	anode (diode 3)		
4	cathode (diode 3)		
5	cathode (diode 2)		1 2 3 sym043
6	cathode (diode 1)	001aab555	, , ,

## 3. Ordering information

Table 4. Ordering information

Type number	umber Package			
	Name	Description	Version	
BAS16VV	-	plastic surface-mounted package; 6 leads	SOT666	
BAS16VY	SC-88	plastic surface-mounted package; 6 leads	SOT363	

## 4. Marking

Table 5. Marking codes

Type number	Marking code <sup>[1]</sup>
BAS16VV	53
BAS16VY	16*

[1] \* = -: made in Hong Kong

\* = p: made in Hong Kong

\* = t: made in Malaysia

\* = W: made in China

## 5. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per diode					
$V_{RRM}$	repetitive peak reverse voltage		-	100	V
$V_R$	reverse voltage		-	100	V
l <sub>F</sub>	forward current		-	200	mΑ
I <sub>FRM</sub>	repetitive peak forward current		-	450	mA
I <sub>FSM</sub>	non-repetitive peak forward	square wave	<u>[1]</u>		
(	current	t <sub>p</sub> = 1 μs	-	4.5	Α
		$t_p = 1 \text{ ms}$	-	1	Α
		t <sub>p</sub> = 1 s	-	0.5	Α
P <sub>tot</sub>	total power dissipation				
	BAS16VV	$T_{amb} \le 25  ^{\circ}C$	[2] _	180	mW
	BAS16VY	T <sub>sp</sub> = 85 °C	[3] _	250	mW
Per device					
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup>  $T_i = 25$  °C prior to surge.

## 6. Thermal characteristics

Table 7. Thermal characteristics

Table 11	Thorna onaraotoriotico					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode						
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air	<u>[1]</u>			
	BAS16VV		[2] _	-	700	K/W
			[3]	-	410	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point					
	BAS16VY		<u>[4]</u> _	-	260	K/W

<sup>[1]</sup> Reflow soldering is the only recommended soldering method.

[4] Soldering points at pins 4, 5 and 6.

<sup>[2]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

<sup>[3]</sup> Soldering points at pins 4, 5 and 6.

<sup>[2]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

<sup>[3]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode 1 cm<sup>2</sup>.

## 7. Characteristics

Table 8. Characteristics

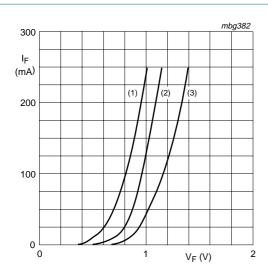
 $T_{amb}$  = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diod	е					
V <sub>F</sub> forward voltage			[1]			
		I <sub>F</sub> = 1 mA	-	-	715	mV
		$I_F = 10 \text{ mA}$	-	-	855	mV
		$I_F = 50 \text{ mA}$	-	-	1	V
		I <sub>F</sub> = 150 mA	-	-	1.25	V
I <sub>R</sub> reverse current	reverse current	V <sub>R</sub> = 25 V	-	-	30	nA
		V <sub>R</sub> = 75 V	-	-	1	μΑ
		$V_R = 25 \text{ V}; T_j = 150 ^{\circ}\text{C}$	-	-	30	μΑ
		$V_R = 75 \text{ V}; T_j = 150 ^{\circ}\text{C}$	-	-	50	μΑ
C <sub>d</sub>	diode capacitance	$V_R = 0 V$ ; $f = 1 MHz$	-	-	1.5	pF
t <sub>rr</sub>	reverse recovery time		[2] _	-	4	ns
$V_{FR}$	forward recovery voltage		[3]	-	1.75	V

<sup>[1]</sup> Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 

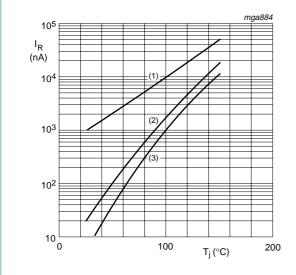
<sup>[2]</sup> When switched from  $I_F$  = 10 mA to  $I_R$  = 10 mA;  $R_L$  = 100  $\Omega;$  measured at  $I_R$  = 1 mA.

<sup>[3]</sup> When switched from  $I_F = 10$  mA;  $t_r = 20$  ns.



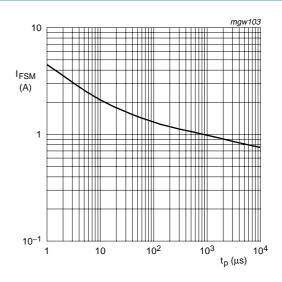
- (1)  $T_{amb} = 150 \,^{\circ}C$ ; typical values
- (2)  $T_{amb} = 25 \,^{\circ}C$ ; typical values
- (3)  $T_{amb} = 25 \,^{\circ}C$ ; maximum values

Fig 1. Forward current as a function of forward voltage



- (1)  $V_R = 75 \text{ V}$ ; maximum values
- (2)  $V_R = 75 V$ ; typical values
- (3)  $V_R = 25 V$ ; typical values

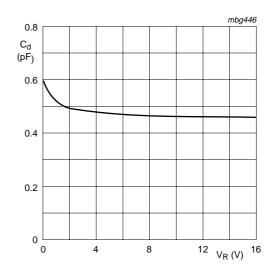
Fig 3. Reverse current as a function of junction temperature



Based on square wave currents.

 $T_i = 25$  °C; prior to surge

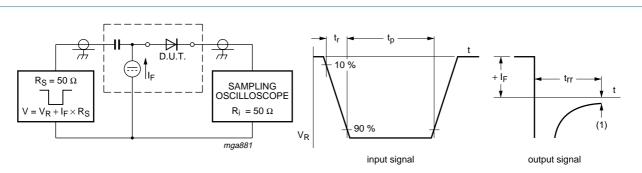
Fig 2. Non-repetitive peak forward current as a function of pulse duration; maximum values



 $f = 1 \text{ MHz}; T_{amb} = 25 ^{\circ}\text{C}$ 

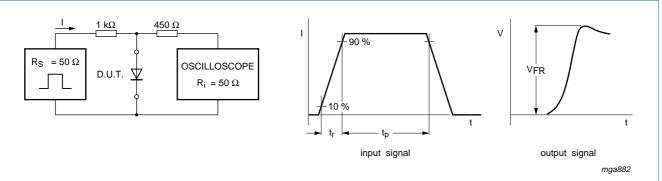
Fig 4. Diode capacitance as a function of reverse voltage; typical values

## 8. Test information



(1)  $I_R$  = 1 mA Input signal: reverse pulse rise time  $t_r$  = 0.6 ns; reverse voltage pulse duration  $t_p$  = 100 ns; duty cycle  $\delta$  = 0.05 Oscilloscope: rise time  $t_r$  = 0.35 ns

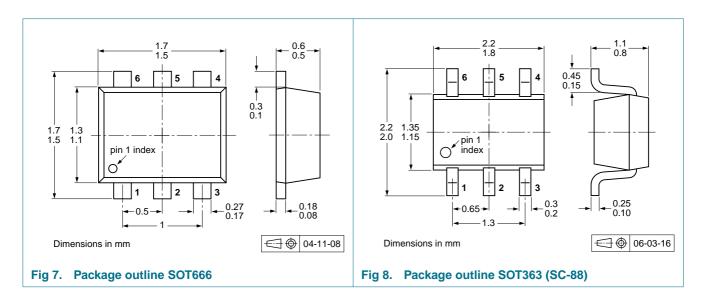
#### Fig 5. Reverse recovery time test circuit and waveforms



Input signal: forward pulse rise time  $t_r = 20$  ns; forward current pulse duration  $t_p \ge 100$  ns; duty cycle  $\delta \le 0.005$ 

Fig 6. Forward recovery voltage test circuit and waveforms

## 9. Package outline



## 10. Packing information

Table 9. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

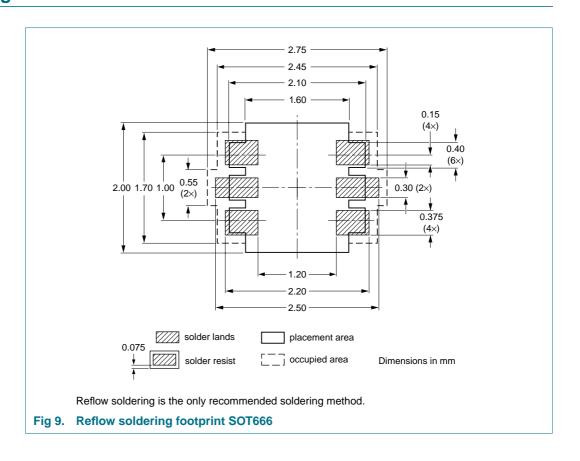
Type number	Type number Package Description		Packing quantity			
			3000	4000	8000	10000
BAS16VV	SOT666	2 mm pitch, 8 mm tape and reel	-	-	-315	-
		4 mm pitch, 8 mm tape and reel	-	-115	-	-
BAS16VY	SOT363	4 mm pitch, 8 mm tape and reel; T1	-115	-	-	-135
		4 mm pitch, 8 mm tape and reel; T2	-125	-	-	-165

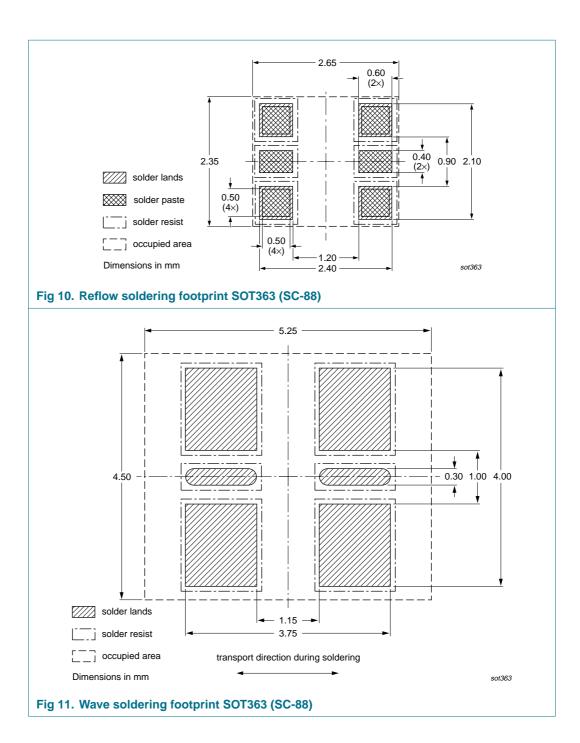
[1] For further information and the availability of packing methods, see <u>Section 14</u>.

[2] T1: normal taping

[3] T2: reverse taping

## 11. Soldering





## 12. Revision history

#### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BAS16VV_BAS16VY_3	20070420	Product data sheet	-	BAS16VV_BAS16VY_2
Modifications:		f this data sheet has beer NXP Semiconductors.	redesigned to comply w	rith the new identity
	<ul> <li>Table 2 "Quic</li> <li>Table 2 "Quic</li> <li>Table 5 "Mark</li> <li>Table 6 "Limit</li> </ul>	ave been adapted to the rick reference data": indicative reference data": Table ricking codes": enhanced taking values": Table note 3	on per diode added note 1 for t <sub>rr</sub> added ole note section amended	re appropriate.
	<ul> <li><u>Table 7 "Thermal characteristics"</u>: indication per diode added</li> <li><u>Table 7 "Thermal characteristics"</u>: R<sub>th(j-s)</sub> thermal resistance from junction to servedefined to R<sub>th(j-sp)</sub> thermal resistance from junction to solder point</li> <li><u>Table 7 "Thermal characteristics"</u>: <u>Table note 2, 3</u> and 4 amended</li> <li>Table 8 "Characteristics": Table note 1 for V<sub>F</sub> added</li> </ul>			
	<ul> <li>Figure 2: figu</li> <li>Figure 4: T<sub>j</sub> ju</li> <li>Figure 5: figu</li> <li>Figure 6: figu</li> </ul>	re title amended unction temperature redef re title and figure note am re note amended	ined to T <sub>amb</sub> ambient ten nended	
	<ul><li>Table 9 "Pack</li><li>Table 9 "Pack</li><li>Section 11 "S</li></ul>	8: superseded by minimized sing methods": packing methods methods methods enhanced soldering: added egal information: update	ethod for SOT666 added table note section	•
BAS16VV_BAS16VY_2	20040910	Product data sheet	-	BAS16VY_1
BAS16VY_1	20030408	Product specification	-	-

## 13. Legal information

#### 13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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#### **NXP Semiconductors**

## Triple high-speed switching diodes

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